

NFC (Near Field Communications)

FCC/IC Test Report

FOR:

Hatchett Entry Systems

Model Name: K200

Product Description: RFID Cabinet Lock

47 CFR Part 15 Subpart C Section 15.209, 15.225 RSS-210 Issue 8, Annex 2, Section 6, RSS-Gen Issue 4

TEST REPORT #: EMC_HANC1-003-15501_15.225_NFC_K200 DATE: 2015-05-06







FCC listed A2LA Accredited

IC recognized # 3462B

CETECOM Inc.

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Test Report #:	EMC_HANC1-003-15501_15.225_NFC_K200	FCC ID: VC3-K200	CETECOM
Date of Report:	2015-05-06	IC ID: 7160A-K200	The state of the s

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1 Assessment

The following device was evaluated against the applicable criteria specified in FCC rules Parts 15.209, 15.225 of Title 47 of the Code of Federal Regulations and Industry Canada Standards RSS-210 Issue 8, Annex 2 and no deviations were ascertained during the course of the tests performed.

Company	Description	Model #
Hatchett Entry	RFID Cabinet Lock	K200
Systems	KI'ID Caullet Lock	K200

This report is reviewed by:

Franz Engert

2015-05-06	Compliance	(Compliance Manager)	
Date	Section	Name	Signature

Responsible for the Report:

		Douglas Antioco	
2015-05-06	Compliance	(EMC Engineer)	
Date	Section	Name	Signature

The test results of this test report relate exclusively to the test item specified in Section3.

CETECOM Inc. USA does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item. The test report may only be reproduced or published in full. Reproduction or publication of extracts from the report requires the prior written approval of the CETECOM Inc USA.

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2 Administrative Data

2.1 Identification of the Testing Laboratory Issuing the Test Report

Company Name:	CETECOM Inc.
Department:	Compliance
Address:	411 Dixon Landing Road Milpitas, CA 95035 U.S.A.
Telephone:	+1 (408) 586 6200
Fax:	+1 (408) 586 6299
Compliance Manager:	Franz Engert
Responsible Project Leader:	Douglas Antioco

2.2 Identification of the Client

Client:	Hatchett Entry Systems	
Street Address: 10027 South 51st Street, Suite 102		
City/Zip Code	Phoenix, Arizona	
Country	The United States of America	
Contact Person: Baruch Spence		
Phone No.	+1 623-582-4626 x7137	
E-mail:	Baruch.spence@assaabloy.com	

2.3 Identification of the Manufacturer

Manufacturer's Name:	
Manufacturers Address:	Same as Client
City/Zip Code:	Same as Chefit
Country:	

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2.4 Environmental conditions during Test:

The following environmental conditions were maintained during the course of testing:

Ambient Temperature: 20 - 25°C Relative humidity: 40-60%

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3 Equipment under Test (EUT)

3.1 Specification of the Equipment under Test

Marketing Name / Model No:	K200
Product Description:	RFID Cabinet Lock
Product Type:	NFC (Near Field Communications), RFID
FCC-ID:	VC3-K200
IC-ID:	7160A-K200
Operating Frequency:	125KHz, 13.56 MHz
Type(s) of Modulation:	ASK (Amplitude Shift Keying)
Number of channels:	1 (per frequency band)
Antenna Info:	 Internal 125 KHz Magnetic Loop antenna Internal 13.56 MHz Magnetic Loop antenna
Rated Operating Voltage Range (DC):	12-24 VDC ± 10%
Operating Temperature Range:	-10 °C to 50 °C
Test Sample status:	Prototype
Other Radios included in the device:	None

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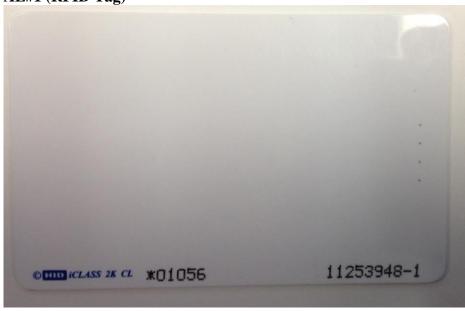
3.2 Identification of the Equipment under Test (EUT)

EUT#	Serial Number	HW Version	Firmware Version	Notes/Comments
1	3085043.002 X03	Main PCBA: Rev. X03 Secure PCBA: Rev. X03 SE3200AP0: Rev. D	Secure PCBA: SVN Rev. 893 SE3200AP0 Core: 0129 SE3200AP0 SAM: 0133	Radiated RF Sample

3.3 Identification of ancillary equipment (used for testing purposes only)

AE#	Туре	Manufacturer	Model	Serial Number
1	RFID Tag	HID Corporation	11253948-1	01295

AE#1 (RFID Tag)



3.4 Dates of Testing:

03/19/2015 - 04/02/2015

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3.5 Testing notes:

- For NFC radios the Carrier conveys all the power available to the transmitter. This power is either radiated off as
 - o A CW signal to carry energy to any NFC tags in the vicinity of the NFC transmitter or
 - The CW carrier is modulated via ASK modulation to carry any information to the tags or other NFC receivers.
- The EUT is constantly transmitting in both Rx and Tx mode. The main difference between the Tx and Rx mode is that the duty cycle of the transmit signal is lower in Tx mode. The output power levels were verified to be the same. This is consistent with both the 125 KHz and 13.56 MHz radios.
- Tx mode is with a 13.56MHz RFID card attached to the receiver. Rx mode is the EUT as standalone device.
- The operating and nominal voltage range is considered to be between 12-24VDC. Unless otherwise noted, nominal voltage was 12 VDC throughout testing.

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4 Subject of Investigation

The objective of the evaluation documented in this report was to assess if the performance of the EUT meets the relevant requirements specified by:

- 47 CFR 2: Title 47 of the Code of Federal Regulations: Chapter I-Federal Communication Commission: Frequency allocations and radio treaty matters; general rules and regulations.
- 47 CFR 15: Title 47 of the Code of Federal Regulations: Chapter I-Federal Communication Commission: Part 15 Radio Frequency Devices Subpart C Intentional Radiators Section 15.225: Operation within the band 13.110-14.010 MHz.
- 47 CFR 15: Title 47 of the Code of Federal Regulations: Chapter I-Federal Communication Commission: Part 15 Radio Frequency Devices Subpart C Intentional Radiators Section 15.209: Radiated emissions limits; general requirements.
- RSS-GEN- Issue 4: General Requirements for Compliance of Radio Apparatus.
- RSS-210- Issue 8: Licence-exempt Radio Apparatus (All Frequency Bands): Category 1 Equipment –Annex 2, section 6: Band 13.110-14.010 MHz

4.1 Dates of Testing:

03/19/2015 - 04/02/2015

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5 <u>Summary of Measurement Results</u>

Test Specification	Test Case	Temperature and Voltage Conditions	Pass	Fail	NA	NP	Result
FCC §15.225 (a) RSS-210 A2.6 (a)	In-band Emissions	Nominal	•				Complies
FCC §15.225 (e) RSS-210 A2.6	Frequency Tolerance	Nominal & Extreme	•				Complies
\$15.209 \$15.225 (d) RSS-Gen 6.13	TX Radiated Spurious Emissions	Nominal					Complies
RSS-Gen 6.6	Occupied Bandwidth	Nominal					Reference Measurement

Note: NA = Not Applicable; NP = Not Performed

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6 In-band Field Strength (Fundamental)

6.1 References

FCC: 15.225 (a) RSS 210: A2.6 (a)

6.2 Limits

FCC: The field strength of any emissions within band 13.553 - 13.567 MHz shall not exceed 15,848 microvolts/meter (84 dBuV/m) at 30 meters distance.

RSS 210: The field strength of any emission shall not exceed the following limits: (a) 15.848 millivolts/m (84 dBµV/m) at 30 meters, within the band 13.553-13.567 MHz.

The 30m limit is converted to 3m, using the 40 dB/decade extrapolation factor formula as specified by FCC part 15.31 (f)(2) for frequencies below 30MHz.

Therefore, 40 dB shall be added to the specified limit (84 dBuV @ 30 m) to convert to actual test limit **124 dBuV** @ 3m.

6.3 Test Conditions

Tnom: 21°C Vnom: 12 V dc

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6.4 Measurement Settings

Ref: ANSI C63.10 Section 4.1.4

Radiated Measurement

RBW = 9kHz (see section 6); VBW = 3 x RBW Span wide enough to capture bandwidth of emission being measured Detector = Peak; Trace = Max Hold Sweep time: Auto.

6.5 Measurement Uncertainty

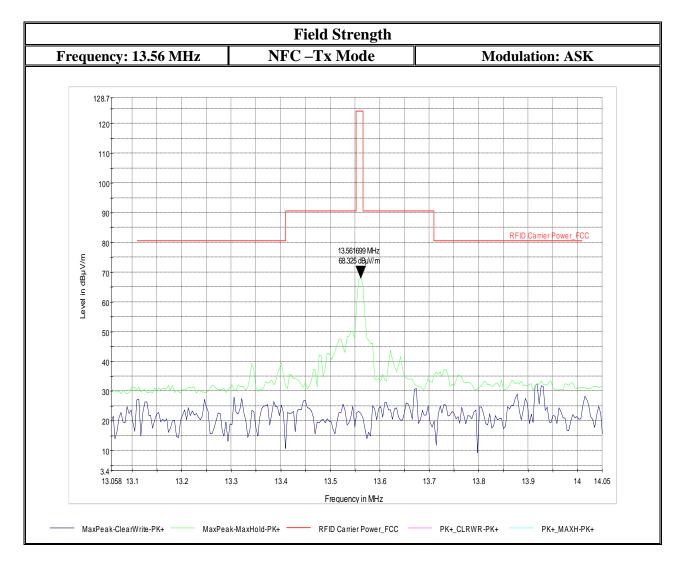
+/-3 dB

6.6 Measurement Verdict

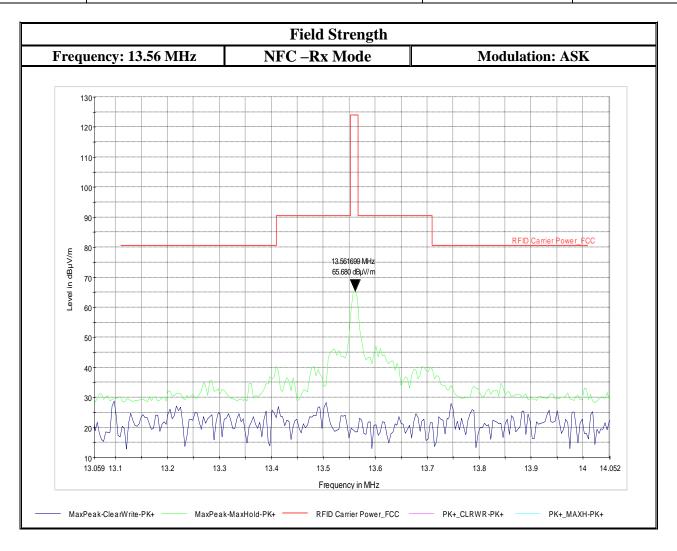
Pass.

Test Report #:	EMC_HANC1-003-15501_15.225_NFC_K200	FCC ID: VC3-K200	CETECOM ™
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6.7 Measurement Plots

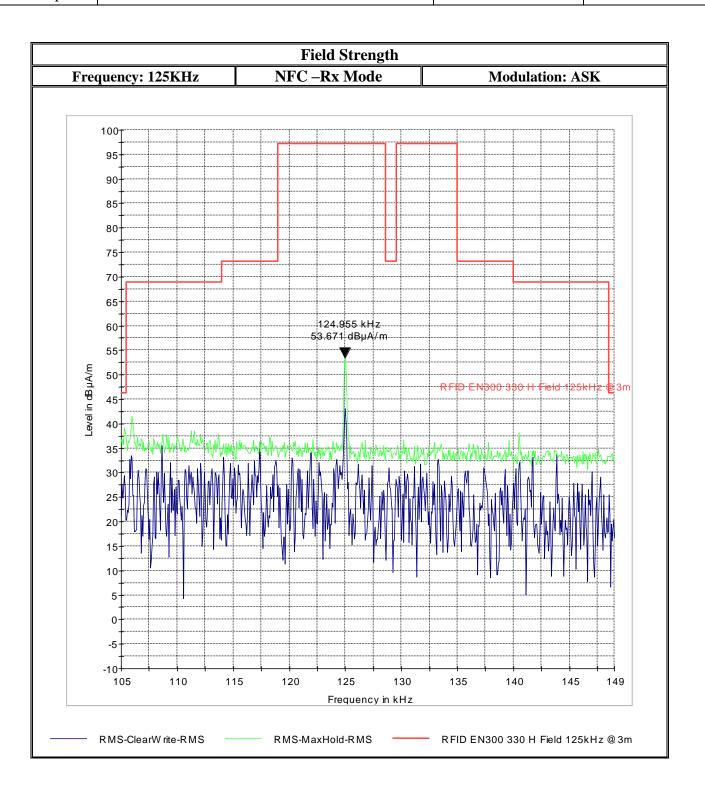


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7 Transmitter Spurious Emissions – Radiated

7.1 Limits

FCC: 15.225 (d) FCC: 15.209 RSS-Gen 6.13

FCC 15.209 & RSS-Gen Section 7.2.5

Frequency (MHz)	Field strength (microvolts/meter)	Measurement distance (m)
0.009-0.490	2400/F(kHz)	300
0.490–1.705	24000/F(kHz)	30
1.705–30.0	30 (29.5 dBμV/m)	30
30–88	100 (40dBμV/m)	3
88–216	150 (43.5 dBμV/m)	3
216–960	200 (46 dBμV/m)	3
Above 960	500 (54 dBμV/m)	3

The 300m and 30m limit is converted to 3m, using the 40 dB/decade extrapolation factor formula as specified by FCC part 15.31 (f)(2) for frequencies below 30MHz.

7.2 Measurement Settings

Ref: ANSI C63.10 Section 4.1.4

Radiated Measurement

RBW=9 kHz for measurements below 30 MHz

RBW=100 kHz for measurements from 30 MHz – 1 GHz

RBW=1 MHz for measurements above 1GHz

VBW≥ 3x RBW

Span= Entire range of measuring antenna or in segment

Detector: Quasi-Peak from 30 MHz – 1 GHz

1GHz < Average < 30 MHz

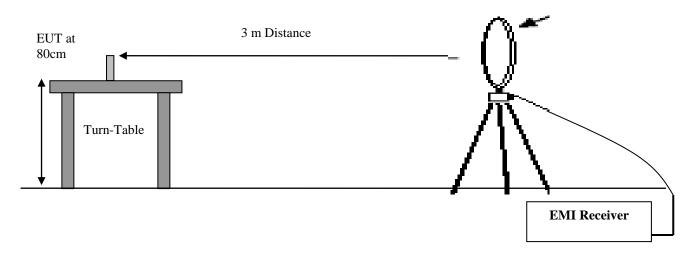
For 125KHz, the EUT is tested in an Rx polling mode which the transmitter is operating at both the 125 KHz and 13.56 MHz frequencies. The EUT also transmits at a higher Duty Cycle in Rx Polling mode which is considered worst case as more energy is required during operation.

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7.3 Radiated Measurement Procedure

Ref: ANSI C63.10 Section 6.4 Field Strength measurement

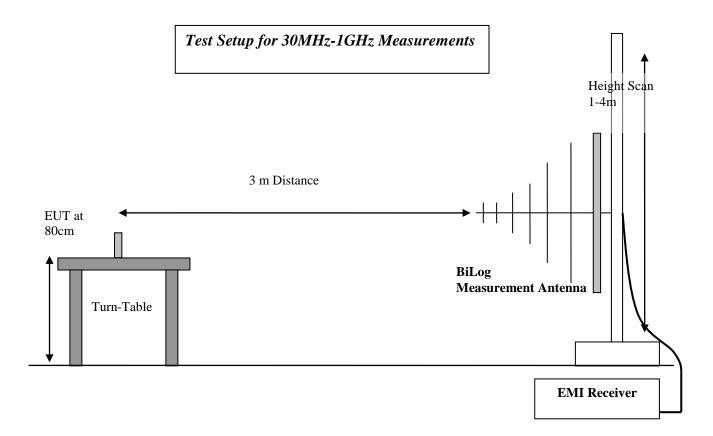
Test Setup for Below 30MHz Measurements



- 1. Connect the equipment as shown in the above diagram with the EUT's antenna in a vertical orientation.
- 2. Set the EUT in continuous transmission mode with its maximum power @ 98% 100% duty cycle.
- 3. Set the spectrum analyzer to the channel frequency of interest.
- 4. Maximize the emission amplitude by rotating the turntable 0 360° , adjusting the measuring antenna height from 1-4 m & changing antenna polarity.
- 5. Repeat steps 4 with all antennas different polarity and determine the maximized polarity for measurement. Measure and record the peak level of field strength (**LVL**) in dBuV.
- 6. Adjust correction factors to the measured field strength (LVL) and using the field strength approach calculation to convert (LVL) from dBuV to transmitter output power (EIRP) in Watts using the following equations:
- 7. Correction factors (**CF**) in dB = Antenna factor (dB) + Cable loss (dB). **LVLc** (dBuV) = **LVL** (dBdBuV) + **Correction Factors** (dB)

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Ref: ANSI C63.10-2013 Section 6.5



7.4 Test Conditions

Tnom: 24°C Vnom: 12 V dc

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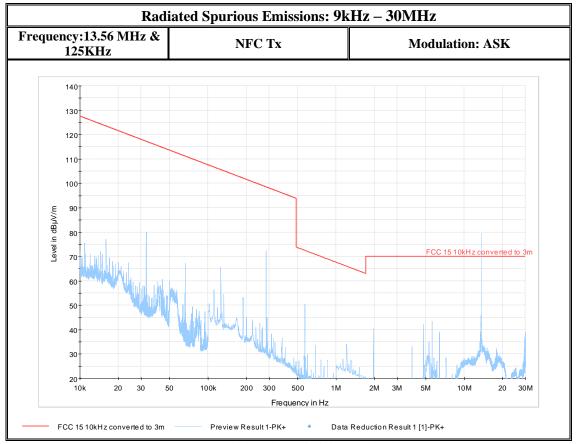
7.5 Measurement Uncertainty +/- 3dB

Measurement Verdict

Pass.

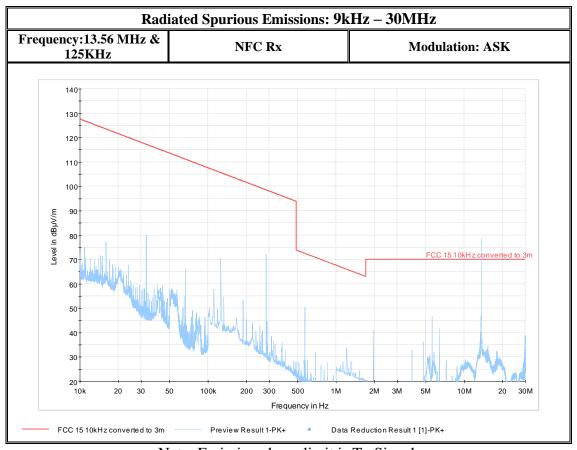
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7.7 Measurement Plots:



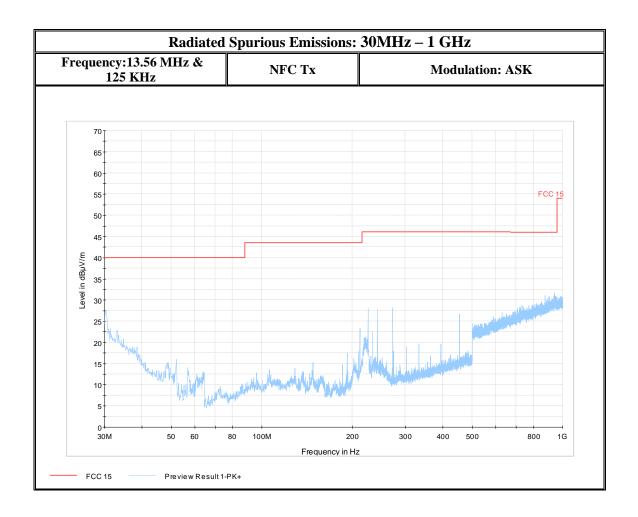
Note: Emission above limit is Tx Signal.

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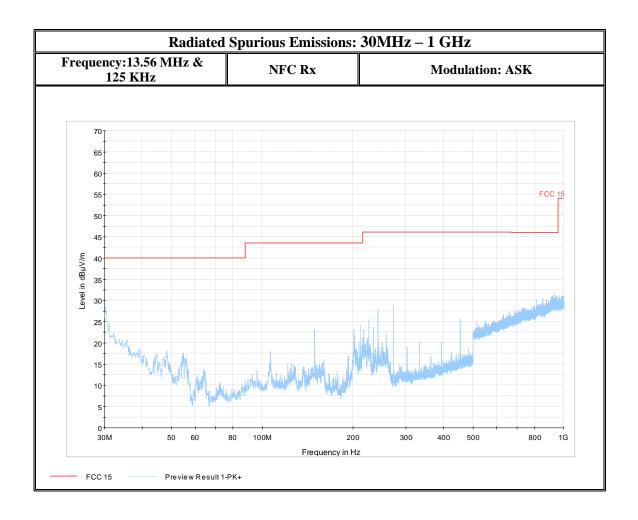


Note: Emission above limit is Tx Signal.

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8 Frequency Tolerance

8.1 References

FCC: 15.225 (e) RSS-210 A2.6

8.2 Limits

 $FCC: \pm 0.01~\% \\ RSS-210: \pm 0.01~\% \\$

8.3 Test Conditions

Tnom: 21°C Vnom: 12 V dc

8.4 Measurement Setting

Radiated measurements were performed. Testing was performed with the EUT in Rx mode.

Spectrum Analyzer Settings

RBW = 1 KHz VBW = 3 KHz Span = 100 KHz Detector = RMS

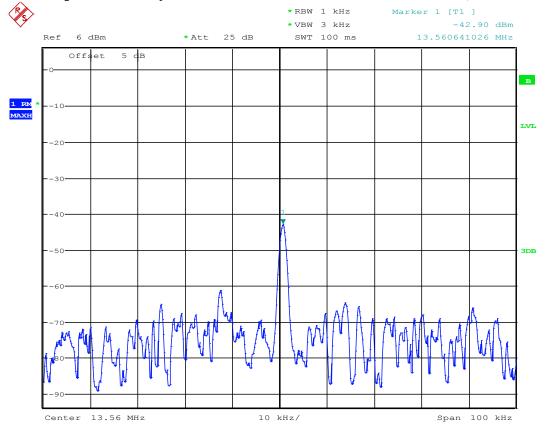
8.5 Test Data

Frequency Tolerance vs. Voltage Source 20 °C Test Mode: NFC Type A				
Voltage Source (Vdc) Measured Frequency (MHz) Tolerance Deviation (%				
Vnom = 12	13.56064103	0.0047		
Vmax = 30	13.56064103	0.0047		
Vmin = 10	13.56064103	0.0047		

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Frequency Tolerance vs. Temperature Test Mode: NFC Type A					
Voltage Source (Vdc)	Temperature (°C)	Measured Frequency (MHz)	Tolerance Deviation (%)		
	50	13.56064103	0.0047		
	40	13.56064103	0.0047		
	30	13.56064103	0.0047		
Vnom = 12	20	13.56064103	0.0047		
VIIOIII – 12	10	13.56064103	0.0047		
	0	13.56064103	0.0047		
	-10	13.56064103	0.0047		
	-20	13.56064103	0.0047		

8.5.1 Spectrum Analyzer Plot at Nominal Conditions (Vnom = 12, Tnom: 21°C)



Date: 3.MAR.2015 13:39:19

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8.6 Measurement Verdict

Pass

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9 Occupied Bandwidth

The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5% of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth of the 99 %.

9.1 References

RSS-Gen 6.6

9.2 Limits

RSS-Gen section 6.6

When an occupied bandwidth value is not specified in the applicable RSS, the transmitted signal bandwidth to be reported is to be its 99% emission bandwidth, as calculated or measured.

9.3 Measurement Settings

Measurement according to RSS-Gen section 6.6

For 99% occupied Bandwidth, use the occupied bandwidth measurement function with the band set equal to 99% emission bandwidth.

Radiated Measurement

Spectrum Analyzer Settings

Span = wide enough to capture all products of the modulation process, including the emission skirts.

RBW = 1% to 5 % of the OBW

VBW = 3X RBW

Sweep = auto

Detector function = peak

Trace = max hold

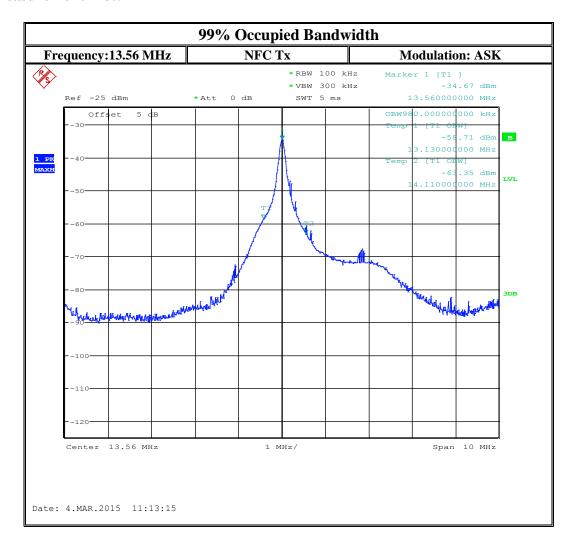
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9.4 Test Data

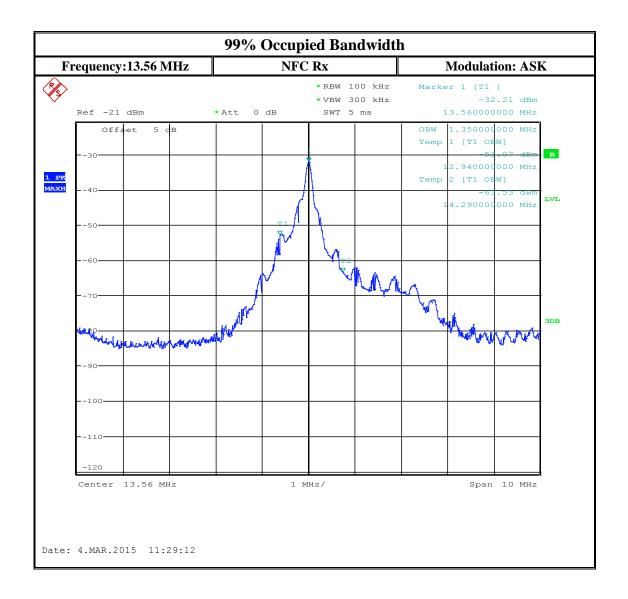
	Occupied Bandwidth			
Mode	Frequency (MHz)	99% BW	Limit (KHz)	Result
Tx	13.56	0.980 MHz	None, as levels are below part 15.209 restricted band limits. (see sect. 6)	Pass
Rx	13.56	1.06 MHz	None, as levels are below part 15.209 restricted band limits. (see sect. 6)	Pass
Rx	0.125	1.66 KHz	None, as levels are below part 15.209 restricted band limits. (see sect. 6)	Pass

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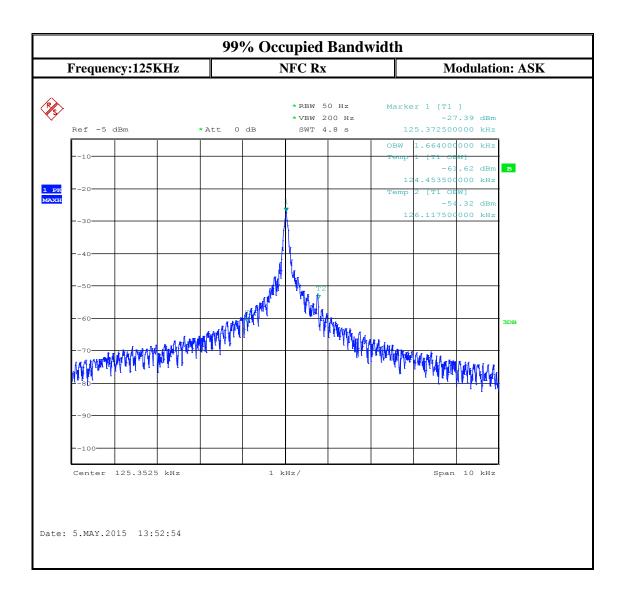
9.5 Measurement Plot:



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10 Test Equipment

Tur MA Ant Rel: EM Spe 150 280 Pre- Loo Bin	Anechoic Chamber: In- band Fieln table PS Position Controller enna Mast ay Switch Unit I Receiver/Analyzer ctrum Analyzer 0MHz HP Filter 0 MHz HP Filter -Amplifier pp Antenna conilog Antenna conilog Antenna	EMCO ETS Lindgren EMCO Rohde&Schwarz Rohde&Schwarz Rohde&Schwarz Filtek Filtek Miteq EMCO EMCO	2075 2092 2075 RSU ESU 40 FSU HP12/1700 HP12/2800 JS40010260 6512	N/A 0004-1510 N/A 338964/001 100251 200302 14c48 14C47 340125	N/A N/A N/A N/A Sept 2013 Jun 2013 N/A N/A N/A	N/A N/A N/A N/A 2 Years 2 Years N/A N/A N/A
MA Ant Rel: EM Spe 150 280 Pre- Loo Bin	PS Position Controller enna Mast ay Switch Unit I Receiver/Analyzer ctrum Analyzer 0MHz HP Filter 0 MHz HP Filter -Amplifier pp Antenna conilog Antenna conilog Antenna	ETS Lindgren EMCO Rohde&Schwarz Rohde&Schwarz Rohde&Schwarz Filtek Filtek Miteq EMCO EMCO	2092 2075 RSU ESU 40 FSU HP12/1700 HP12/2800 JS40010260 6512	0004-1510 N/A 338964/001 100251 200302 14c48 14C47 340125	N/A N/A N/A Sept 2013 Jun 2013 N/A N/A	N/A N/A N/A 2 Years 2 Years N/A N/A
Ant Rela EM Spe 150 280 Pre- Loo Bin	enna Mast ay Switch Unit I Receiver/Analyzer ctrum Analyzer 0MHz HP Filter 0 MHz HP Filter -Amplifier pp Antenna conilog Antenna conilog Antenna	EMCO Rohde&Schwarz Rohde&Schwarz Rohde&Schwarz Filtek Filtek Miteq EMCO EMCO	2075 RSU ESU 40 FSU HP12/1700 HP12/2800 JS40010260 6512	N/A 338964/001 100251 200302 14c48 14C47 340125	N/A N/A Sept 2013 Jun 2013 N/A N/A	N/A N/A 2 Years 2 Years N/A N/A
Reli EM Spe 150 280 Pre- Loo Bin	ay Switch Unit I Receiver/Analyzer ctrum Analyzer OMHz HP Filter O MHz HP Filter -Amplifier op Antenna conilog Antenna conilog Antenna	Rohde&Schwarz Rohde&Schwarz Rohde&Schwarz Filtek Filtek Miteq EMCO EMCO	RSU ESU 40 FSU HP12/1700 HP12/2800 JS40010260 6512	338964/001 100251 200302 14c48 14C47 340125	N/A Sept 2013 Jun 2013 N/A N/A	N/A 2 Years 2 Years N/A N/A
EM Spe 150 280 Pre-Loo Bin	I Receiver/Analyzer ctrum Analyzer OMHz HP Filter O MHz HP Filter -Amplifier pp Antenna conilog Antenna conilog Antenna	Rohde&Schwarz Rohde&Schwarz Filtek Filtek Miteq EMCO EMCO	ESU 40 FSU HP12/1700 HP12/2800 JS40010260 6512	100251 200302 14c48 14C47 340125	Sept 2013 Jun 2013 N/A N/A	2 Years 2 Years N/A N/A
Spe 150 280 Pre- Loc Bin	ctrum Analyzer OMHz HP Filter O MHz HP Filter -Amplifier p Antenna conilog Antenna conilog Antenna	Rohde&Schwarz Filtek Filtek Miteq EMCO EMCO	FSU HP12/1700 HP12/2800 JS40010260 6512	200302 14c48 14C47 340125	Jun 2013 N/A N/A	2 Years N/A N/A
150 280 Pre- Loc Bin	0MHz HP Filter 0 MHz HP Filter -Amplifier -p Antenna conilog Antenna conilog Antenna	Filtek Filtek Miteq EMCO EMCO	HP12/1700 HP12/2800 JS40010260 6512	14c48 14C47 340125	N/A N/A	N/A N/A
280 Pre- Loo Bin	0 MHz HP Filter -Amplifier -p Antenna conilog Antenna conilog Antenna	Filtek Miteq EMCO EMCO	HP12/2800 JS40010260 6512	14C47 340125	N/A	N/A
Pre- Loc Bin	-Amplifier op Antenna conilog Antenna conilog Antenna	Miteq EMCO EMCO	JS40010260 6512	340125		
Loc Bin	p Antenna conilog Antenna conilog Antenna	EMCO EMCO	6512		N/A	NI/A
Bin	conilog Antenna conilog Antenna	EMCO				1 N / / A
	conilog Antenna	EMCO		00049838	Apr 2012	3 years
Rin			3141	0005-1186	Apr 2012	3 Years
Dill	n Antenna	ETS	3149	J000123908	Feb 2012	3 years
Hor		EMCO	3115	35114	Mar 2012	3 Years
LIS	N	R&S	ESH3-Z5	836679/003	Jun 2013	3 Years
Ten	np Hum Logger	TM325	Dickson	5285354	Apr 2013	2 Year
Clir	natic Chamber	Votsch	VT4004	G1115	N/A	N/A
3m Semi- A	Anechoic Chamber: Transmitter	Spurious Emissions Testi	ng			
Spe	ctrum Analyzer	Rohde and Schwarz	FSU 26	200302	Jun 2013	2 years
Spe	ctrum Analyzer	Rohde and Schwarz	FSV 40	0547	Jul 2014	2 years
Rec	eiver	Rohde and Schwarz	ESR3	101663	Feb2013	3 years
LIS	N	Rohde and Schwarz	ENV 216	101129	Jan 2013	3 years
Rad	lio Communications Tester	Rohde and Schwarz	CMU 200	121672	Jul 2013	2 years
Log	Periodic Antenna	Rohde and Schwarz	HL 050	100515	Apr 2013	3 year
Ultı	alog Antenna	Rohde and Schwarz	HL 562	100495	Feb 2012	4 year
180		ETS-Lindgren	3117-PA	00167061	Aug 2014	3 year
	uble-ridge Horn Antenna G-40G)	ETS-Lindgren	3116C-PA	00166821	Aug 2014	3 year
Loc	p Antenna	ETS-Lindgren	6512	00164698	Jul 2014	3 year
Ope	en Switch Control Unit	Rohde and Schwarz	OPS 130	10085	n/a	n/a
	ention Unit Open Switch atrol Unit	Rohde and Schwarz	OSP 150	10086	n/a	n/a
Tur	n Table TT	Maturo	1.5 SI	TT 1.5SI/204/6070 910	n/a	n/a
Cor	npact antenna Mast	Maturo	CAM 4.0-P	CAM4.0- P/067/6000910	n/a	n/a
	Itiple Control Unit	Maturo	MCU	2140910	n/a	n/a
	-Amplifier	Rohde and Schwarz	TS-PR 18	100072		•
	h Pass Filter	Mini-Circuits	SHP-1200+	RUU11201224	Part of th	
	h Pass Filter	Wainwright Instr.	WHKX 3.0/18	109	calibr	ation
Ancillary e		sair sair i i i i i i i i i i i i i i i i i i	1			
	ctrum Analyzer	Rohde&Schwarz	FSU	200065	Jun 2013	2 Years
_	np Hum Logger	TM325	Dickson	5285354	Apr 2013	2 Year
	natic Chamber	Votsch	VT4004	G1115	N/A	N/A

Equipment used meets the measurement uncertainty requirements as required per applicable standards for 95% confidence levels. Calibration due dates, unless defined specifically, falls on the last day of the month.

Items indicated "N/A" for cal status either do not specifically require calibration or is internally characterized before use.

Test Report #:	EMC_HANC1-003-15501_15.225_NFC_K200	FCC ID: VC3-K200	CETECOM
Date of Report:	2015-05-06	IC ID: 7160A-K200	The state of the s

11 Revision History

Date	Report Name	Changes to report	Report prepared by
2015-05-06	EMC_HANC1-003-15501_15.225_NFC_K200	First version	Douglas Antioco